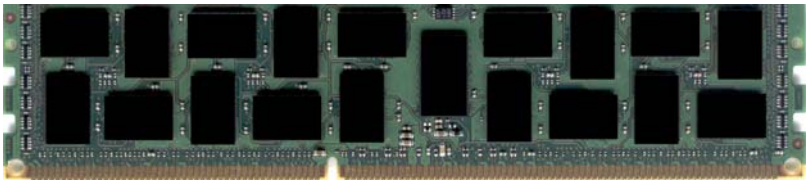
DTM64316E

8GB - 240-Pin 2Rx4 Registered ECC DDR3 DIMM



Identification

DTM64316E 1Gx72

8GB 2Rx4 PC3-10600R-9-E1

Performance range

Clock / Module Speed / CL-t_{RCD} -t_{RP}

667 MHz / PC3-10600 / 9-9-9

533 MHz / PC3-8500 / 8-8-8

533 MHz / PC3-8500 / 7-7-7

400 MHz / PC3-6400 / 6-6-6

Features

- 240-pin JEDEC-compliant DIMM, 133.35 mm wide by 30 mm high
- Operating Voltage: 1.5V ±0.075
- I/O Type: SSTL_15
- On-board I^2C temperature sensor with integrated Serial Presence-Detect (SPD) EEPROM
- Data Transfer Rate: 10.6 Gigabytes/sec
- Data Bursts: 8 and burst chop 4 mode
- ZQ Calibration for Output Driver and On-Die Termination (ODT)
- Programmable ODT / Dynamic ODT during Writes
- Programmable CAS Latency: 6, 7, 8 and 9
- Bi-directional Differential Data Strobe signals
- SDRAM Addressing (Row/Col/Bank): 15/11/3
- Fully RoHS Compliant

Description

DTM64316E is a registered 1Gx72 memory module, which conforms to JEDEC's DDR3, PC3-10600 standard. The assembly is Dual-Rank. Each Rank is comprised of eighteen 512Mx4 DDR3-1333 Samsung SDRAMs. One 2K-bit EEPROM is used for Serial Presence Detect and a combination register/PLL, with Address and Command Parity, is also used.

Both output driver strength and input termination impedance are programmable to maintain signal integrity on the I/O signals in a Fly-by topology. A thermal sensor accurately monitors the DIMM module and can prevent exceeding the maximum operating temperature of 95C.

Pin Configuration

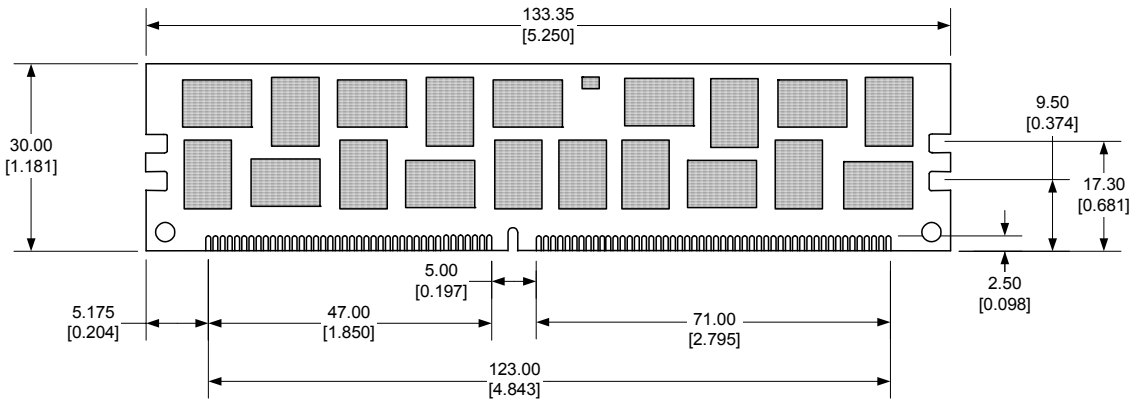
Front Side								Back Side							
1	V_{REFDQ}	31	DQ25	61	A2	91	DQ41	121	V_{SS}	151	V_{SS}	181	A1	211	V_{SS}
2	V_{SS}	32	V_{SS}	62	V_{DD}	92	V_{SS}	122	DQ4	152	DQS12	182	V_{DD}	212	DQS14
3	DQ0	33	/DQS3	63	CK1*	93	/DQS5	123	DQ5	153	/DQS12	183	V_{DD}	213	/DQS14
4	DQ1	34	DQS3	64	/CK1*	94	DQS5	124	V_{SS}	154	V_{SS}	184	CK0	214	V_{SS}
5	V_{SS}	35	V_{SS}	65	V_{DD}	95	V_{SS}	125	DQS9	155	DQ30	185	/CK0	215	DQ46
6	/DQS0	36	DQ26	66	V_{DD}	96	DQ42	126	/DQS9	156	DQ31	186	V_{DD}	216	DQ47
7	DQS0	37	DQ27	67	V_{REFCA}	97	DQ43	127	V_{SS}	157	V_{SS}	187	/EVENT	217	V_{SS}
8	V_{SS}	38	V_{SS}	68	P_{AR_IN}	98	V_{SS}	128	DQ6	158	CB4	188	A0	218	DQ52
9	DQ2	39	CB0	69	VDD	99	DQ48	129	DQ7	159	CB5	189	V_{DD}	219	DQ53
10	DQ3	40	CB1	70	A10/AP	100	DQ49	130	V_{SS}	160	V_{SS}	190	BA1	220	V_{SS}
11	V_{SS}	41	V_{SS}	71	BA0	101	V_{SS}	131	DQ12	161	DQS17	191	V_{DD}	221	DQS15
12	DQ8	42	/DQS8	72	V_{DD}	102	/DQS6	132	DQ13	162	/DQS17	192	/RAS	222	/DQS15
13	DQ9	43	DQS8	73	/WE	103	DQS6	133	V_{SS}	163	V_{SS}	193	/S0	223	V_{SS}
14	V_{SS}	44	V_{SS}	74	/CAS	104	V_{SS}	134	DQS10	164	CB6	194	V_{DD}	224	DQ54
15	/DQS1	45	CB2	75	V_{DD}	105	DQ50	135	/DQS10	165	CB7	195	ODT0	225	DQ55
16	DQS1	46	CB3	76	/S1	106	DQ51	136	V_{SS}	166	V_{SS}	196	A13	226	V_{SS}
17	V_{SS}	47	V_{SS}	77	ODT1	107	V_{SS}	137	DQ14	167	NC (TEST)	197	V_{DD}	227	DQ60
18	DQ10	48	V_{TT}	78	V_{DD}	108	DQ56	138	DQ15	168	/RESET	198	/S3, NC	228	DQ61
19	DQ11	49	V_{TT}	79	/S2, NC	109	DQ57	139	V_{SS}	169	CKE1	199	V_{SS}	229	V_{SS}
20	V_{SS}	50	CKE0	80	V_{SS}	110	V_{SS}	140	DQ20	170	V_{DD}	200	DQ36	230	DQS16
21	DQ16	51	V_{DD}	81	DQ32	111	/DQS7	141	DQ21	171	A15	201	DQ37	231	/DQS16
22	DQ17	52	BA2	82	DQ33	112	DQS7	142	V_{SS}	172	A14	202	V_{SS}	232	V_{SS}
23	V_{SS}	53	$/E_{RR_OUT}$	83	V_{SS}	113	V_{SS}	143	DQS11	173	V_{DD}	203	DQS13	233	DQ62
24	/DQS2	54	V_{DD}	84	/DQS4	114	DQ58	144	/DQS11	174	A12/BC	204	/DQS13	234	DQ63
25	DQS2	55	A11	85	DQS4	115	DQ59	145	V_{SS}	175	A9	205	V_{SS}	235	V_{SS}
26	V_{SS}	56	A7	86	V_{SS}	116	V_{SS}	146	DQ22	176	V_{DD}	206	DQ38	236	V_{DDSPD}
27	DQ18	57	V_{DD}	87	DQ34	117	SA0	147	DQ23	177	A8	207	DQ39	237	SA1
28	DQ19	58	A5	88	DQ35	118	SCL	148	V_{SS}	178	A6	208	V_{SS}	238	SDA
29	V_{SS}	59	A4	89	V_{SS}	119	SA2	149	DQ28	179	V_{DD}	209	DQ44	239	V_{SS}
30	DQ24	60	V_{DD}	90	DQ40	120	V_{TT}	150	DQ29	180	A3	210	DQ45	240	V_{TT}

* Not used

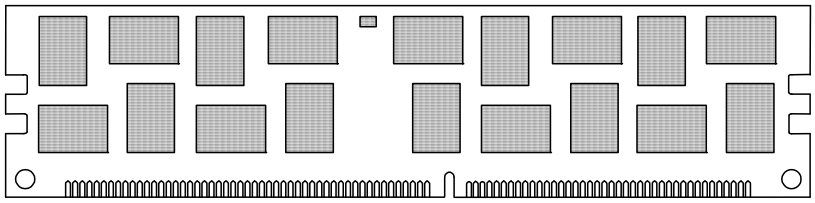
Pin Description

Name	Function
CB[7:0]	Data Check Bits
DQ[63:0]	Data Bits
DQS[17:0], /DQS[17:0]	Differential Data Strobes
CK[1:0], /CK[1:0]	Differential Clock Inputs
CKE[1:0]	Clock Enables
/CAS	Column Address Strobe
/RAS	Row Address Strobe
/S[3:0]	Chip Selects
/WE	Write Enable
A[15:0]	Address Inputs
BA[2:0]	Bank Addresses
ODT[1:0]	On Die Termination Inputs
SA[2:0]	SPD Address
SCL	SPD Clock Input
SDA	SPD Data Input/Output
/EVENT	Temperature Sensing
/RESET	Reset for register and DRAMs
PAR_IN	Parity bit for Addr/Ctrl
/ERR_OUT	Error bit for Parity Error
A12/BC	Combination input: Addr12/Burst Chop
A10/AP	Combination input: Addr10/Auto-precharge
V_{SS}	Ground
V_{DD}	Power
V_{DDSPD}	SPD EEPROM Power
V_{REFDQ}	Reference Voltage for DQ's
V_{REFCA}	Reference Voltage for CA
V_{TT}	Termination Voltage
NC	No Connection

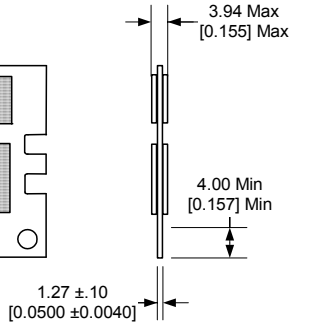
Front view



Back view



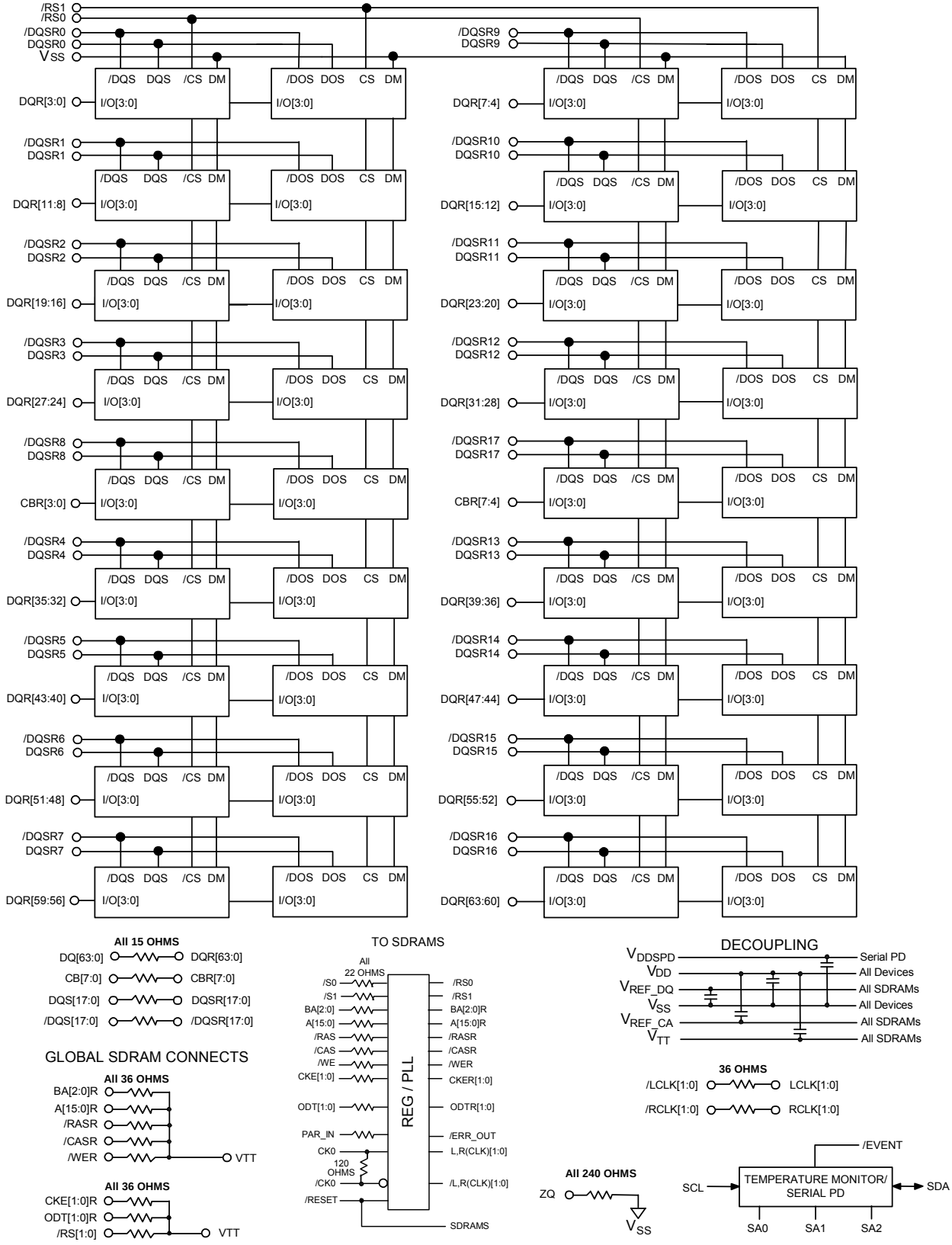
Side view



Notes

Tolerances on all dimensions except where otherwise indicated are ±.13 (.005).

All dimensions are expressed: millimeters [inches]


/RS1
/RS0
/DQSR0
DQSR0
VSS
/DQSR9
DQSR9
/DQS DQS /CS DM
/DOS DOS CS DM
I/O[3:0]
DQR[3:0]
DQR[7:4]
/DQSR1
DQSR1
/DQSR10
DQSR10
DQR[11:8]
DQR[15:12]
/DQSR2
DQSR2
/DQSR11
DQSR11
DQR[19:16]
DQR[23:20]
/DQSR3
DQSR3
/DQSR12
DQSR12
DQR[27:24]
DQR[31:28]
/DQSR8
DQSR8
/DQSR17
DQSR17
CBR[3:0]
CBR[7:4]
/DQSR4
DQSR4
/DQSR13
DQSR13
DQR[35:32]
DQR[39:36]
/DQSR5
DQSR5
/DQSR14
DQSR14
DQR[43:40]
DQR[47:44]
/DQSR6
DQSR6
/DQSR15
DQSR15
DQR[51:48]
DQR[55:52]
/DQSR7
DQSR7
/DQSR16
DQSR16
DQR[59:56]
DQR[63:60]

All 15 OHMS
DQ[63:0]
DQR[63:0]
CB[7:0]
CBR[7:0]
DQS[17:0]
DQSR[17:0]
/DQS[17:0]
/DQSR[17:0]

GLOBAL SDRAM CONNECTS
All 36 OHMS
BA[2:0]R
A[15:0]R
/RASR
/CASR
/WER
VTT
All 36 OHMS
CKE[1:0]R
ODT[1:0]R
/RS[1:0]
VTT

TO SDRAMS
All
22 OHMS
/S0
/S1
BA[2:0]
A[15:0]
/RAS
/CAS
/WE
CKE[1:0]
ODT[1:0]
PAR_IN
CK0
120
OHMS
/CK0
/RESET
REG / PLL
/RS0
/RS1
BA[2:0]R
A[15:0]R
/RASR
/CASR
/WER
CKER[1:0]
ODTR[1:0]
/ERR_OUT
L,R(CLK)[1:0]
/L,R(CLK)[1:0]
SDRAMS

All 240 OHMS
ZQ
VSS

DECOUPLING
VDDSPD
Serial PD
VDD
All Devices
VREF_DQ
All SDRAMs
VSS
All Devices
VREF_CA
All SDRAMs
VTT
All SDRAMs
36 OHMS
/LCLK[1:0]
LCLK[1:0]
/RCLK[1:0]
RCLK[1:0]

/EVENT
SCL
TEMPERATURE MONITOR/
SERIAL PD
SDA
SA0
SA1
SA2

Absolute Maximum Ratings
(Note: Operation at or above Absolute Maximum Ratings can adversely affect module reliability.)

PARAMETER	Symbol	Minimum	Maximum	Unit
Temperature, non-Operating	$T_{STORAGE}$	-55	100	C
Ambient Temperature, Operating	T_A	0	70	C
DRAM Case Temperature, Operating	T_{CASE}	0	95	C
Voltage on V_{DD} relative to V_{SS}	V_{DD}	-0.4	1.975	V
Voltage on Any Pin relative to V_{SS}	V_{IN},V_{OUT}	-0.4	1.975	V

Notes:
DRAM Operating Case Temperature above 85C requires 2X refresh.

Recommended DC Operating Conditions (T_A = 0 to 70 C, Voltage referenced to V_{ss} = 0 V)

PARAMETER	Symbol	Minimum	Typical	Maximum	Unit	Note
Power Supply Voltage	V_{DD}	1.425	1.5	1.575	V	
I/O Reference Voltage	V_{REFDQ}	0.49 V_{DD}	0.50 V_{DD}	0.51 V_{DD}	V	1
I/O Reference Voltage	V_{REFCA}	0.49 V_{DD}	0.50 V_{DD}	0.51 V_{DD}	V	1

Notes:
1) The value of V_{REF} is expected to equal one-half V_{DD} and to track variations in the V_{DD} DC level. Peak-to-peak noise on V_{REF} may not exceed ±1% of its DC value.

DC Input Logic Levels, Single-Ended (T_A = 0 to 70 C, Voltage referenced to V_{ss} = 0 V)

PARAMETER	Symbol	Minimum	Maximum	Unit
Logical High (Logic 1)	$V_{IH(DC)}$	V_{REF} + 0.1	V_{DD}	V
Logical Low (Logic 0)	$V_{IL(DC)}$	V_{SS}	V_{REF} - 0.1	V

AC Input Logic Levels, Single-Ended (T_A = 0 to 70 C, Voltage referenced to V_{ss} = 0 V)

PARAMETER	Symbol	Minimum	Maximum	Unit
Logical High (Logic 1)	$V_{IH(AC)}$	V_{REF} + 0.175	-	V
Logical Low (Logic 0)	$V_{IL(AC)}$	-	V_{REF} - 0.175	V

Differential Input Logic Levels (T_A = 0 to 70 C, Voltage referenced to V_{ss} = 0 V)

PARAMETER	Symbol	Minimum	Maximum	Unit
Differential Input Logic High	$V_{IH.DIFF}$	+0.200	DC:V_{DD} AC:V_{DD}+0.4	V
Differential Input Logic Low	$V_{IL.DIFF}$	DC:V_{SS} AC:V_{SS}-0.4	-0.200	V
Differential Input Cross Point Voltage relative to VDD/2	V_{IX}	- 0.150	+ 0.150	V

Capacitance (T_A = 25 C, f = 100 MHz)

PARAMETER	Pin	Symbol	Minimum	Maximum	Unit
Input Capacitance, Clock	CK0, /CK0	C_{CK}	1.5	2.5	pF
Input Capacitance, Address	BA[2:0], A[15:0], /RAS, /CAS, /WE	C_I	1.5	2.5	pF
Input Capacitance Control	/S[1:0], CKE[1:0], ODT[1:0]	C_I	1.5	2.5	pF
Input/Output Capacitance	DQ[63:0], CB[7:0] DQS[17:0], /DQS[17:0].	C_{IO}	3	5	pF

DC Characteristics (T_A = 0 to 70 C, Voltage referenced to V_{ss} = 0 V)

PARAMETER	Symbol	Minimum	Maximum	Unit	Note
Input Leakage Current (Any input 0 V < VIN < VDD)	I_{IL}	-18	+18	µA	1,2
Output Leakage Current (0V < VOUT < VDDQ)	I_{OL}	-10	+10	µA	2,3

Notes:
1) All other pins not under test = 0 V
2) Values are shown per pin
3) DQ, DQS, DQS and ODT are disabled

I_{DD} Specifications and Conditions (T_A = 0 to 70 C, Voltage referenced to V_{ss} = 0 V)

PARAMETER	Symbol	Test Condition	Max Value	Unit
Operating One Bank Active-Precharge Current	$I_{DD}0$*	Operating current : One bank ACTIVATE-to-PRECHARGE	2420	mA
Operating One Bank Active-Read-Precharge Current	$I_{DD}1$*	Operating current : One bank ACTIVATE-to-READ-to-PRECHARGE	2600	mA
Precharge Power-Down Current	$I_{DD}2P$**	Precharge power down current: (Slow exit)	1042	mA
Precharge Power-Down Current	$I_{DD}2P$**	Precharge power down current: (Fast exit)	1330	mA
Precharge Standby Current	$I_{DD}2N$**	Precharge standby current	1940	mA
Active Power-Down Current	$I_{DD}3P$**	Active power-down current	1690	mA
Active Standby Current	$I_{DD}3N$**	Active standby current	2650	mA
Operating Burst Write Current	$I_{DD}4W$*	Burst write operating current	3510	mA
Operating Burst Read Current	$I_{DD}4R$*	Burst read operating current	3140	mA
Burst Refresh Current	$I_{DD}5B$**	Refresh current	4360	mA
Self Refresh Current	$I_{DD}6$**	Self-refresh temperature current: MAX T_C = 85°C	1032	mA
Operating Bank Interleave Read Current	$I_{DD}7$*	All bank interleaved read current	4940	mA

* One module rank in this operation, the rest in IDD2P slow exit.
** All module ranks in this operation.

AC Operating Conditions

PARAMETER	Symbol	Min	Max	Unit
Internal read command to first data	t_{AA}	13.125	20	ns
CAS-to-CAS Command Delay	t_{CCD}	4	-	t_{CK}
Clock High Level Width	$t_{CH(avg)}$	0.47	0.53	t_{CK}
Clock Cycle Time	t_{CK}	1.5	1.875	ns
Clock Low Level Width	$t_{CL(avg)}$	0.47	0.53	t_{CK}
Data Input Hold Time after DQS Strobe	t_{DH}	65	-	ps
DQ Input Pulse Width	t_{DIPW}	400	-	ps
DQS Output Access Time from Clock	t_{DQSCK}	-255	+255	ps
Write DQS High Level Width	t_{DQSH}	0.45	0.55	$t_{CK(avg)}$
Write DQS Low Level Width	t_{DQSL}	0.45	0.55	$t_{CK(avg)}$
DQS-Out Edge to Data-Out Edge Skew	t_{DQSQ}	-	125	ps
Data Input Setup Time Before DQS Strobe	t_{DS}	30	-	ps
DQS Falling Edge from Clock, Hold Time	t_{DSH}	0.2	-	$t_{CK(avg)}$
DQS Falling Edge to Clock, Setup Time	t_{DSS}	0.2	-	$t_{CK(avg)}$
Clock Half Period	t_{HP}	minimum of t_{CH} or t_{CL}	-	ns
Address and Command Hold Time after Clock	t_{IH}	140	-	ps
Address and Command Setup Time before Clock	t_{IS}	65	-	ps
Load Mode Command Cycle Time	t_{MRD}	4	-	t_{CK}
DQ-to-DQS Hold	t_{QH}	0.38	-	$t_{CK(avg)}$
Active-to-Precharge Time	t_{RAS}	36	$9*t_{REFI}$	ns
Active-to-Active / Auto Refresh Time	t_{RC}	49.125	-	ns
RAS-to-CAS Delay	t_{RCD}	13.125	-	ns
Average Periodic Refresh Interval 0^{o} C $\leq T_{CASE} < 85^{o}$ C	t_{REFI}	-	7.8	µs
Average Periodic Refresh Interval 0^{o} C $\leq T_{CASE} < 95^{o}$ C	t_{REFI}	-	3.9	µs
Auto Refresh Row Cycle Time	t_{RFC}	160	-	ns
Row Precharge Time	t_{RP}	13.125	-	ns
Read DQS Preamble Time	t_{RPRE}	0.9	Note-1	$t_{CK(avg)}$
Read DQS Postamble Time	t_{RPST}	0.3	Note-2	$t_{CK(avg)}$
Row Active to Row Active Delay	t_{RRD}	Max(4nCK, 6ns)	-	ns
Internal Read to Precharge Command Delay	t_{RTP}	Max(4nCK, 7.5ns)	-	ns
Write DQS Preamble Setup Time	t_{WPRE}	0.9	-	$t_{CK(avg)}$
Write DQS Postamble Time	t_{WPST}	0.3	-	$t_{CK(avg)}$
Write Recovery Time	t_{WR}	15	-	ns
Internal Write to Read Command Delay	t_{WTR}	Max(4nCK, 7.5ns)	-	ns

Notes:
1. The maximum preamble is bound by tLZDQS(min)
2. The maximum postamble is bound by tHZDQS(max)

Serial Presence Detect

Byte#	Function.	Value	Hex
0	Number of Bytes Used / Number of Bytes in SPD Device / CRC Coverage		0x92
	Bit 3 ~ Bit 0. SPD Bytes Used -	176	
	Bit 6 ~ Bit 4. SPD Bytes Total -	256	
	Bit 7. CRC Coverage -	Bytes 0-116	
1	SPD Revision	Rev. 1.0	0x10
2	Key Byte / DRAM Device Type	DDR3 SDRAM	0x0B
3	Key Byte / Module Type		0x01
	Bit 3 ~ Bit 0. Module Type -	RDIMM	
	Bit 7 ~ Bit 4. Reserved -	0	
4	SDRAM Density and Banks.		0x03
	Bit 3 ~ Bit 0. Total SDRAM capacity, in megabits -	2Gb	
	Bit 6 ~ Bit 4. Bank Address Bits -	8 banks	
	Bit 7. Reserved -	0	
5	SDRAM Addressing.		0x1A
	Bit 2 ~ Bit 0. Column Address Bits -	11	
	Bit 5 ~ Bit 3. Row Address Bits -	15	
	Bit 7, 6. Reserved	0	
6	Reserved.		0x00
7	Module Organization.		0x08
	Bit 2 ~ Bit 0. SDRAM Device Width -	4-Bits	
	Bit 5 ~ Bit 3. Number of Ranks -	2-Rank	
	Bit 7, 6. Reserved	0	
8	Module Memory Bus Width.		0x0B
	Bit 2 ~ Bit 0. Primary bus width, in bits -	64-Bits	
	Bit 4, Bit 3. Bus width extension, in bits -	8-Bits	
	Bit 7 ~ Bit 5. Reserved -	0	
9	Fine Timebase (FTB) Dividend / Divisor.		0x52
	Bit 3 ~ Bit 0. Fine Timebase (FTB) Divisor	2	
	Bit 7 ~ Bit 4. Fine Timebase (FTB) Dividend	5	
10	Medium Timebase (MTB) Dividend.	1 (MTB = 0.125ns)	0x01
11	Medium Timebase (MTB) Divisor.	8 (MTB = 0.125ns)	0x08
12	SDRAM Minimum Cycle Time (tCKmin).	1.5ns	0x0C
13	Reserved.	UNUSED	0x00
14	CAS Latencies Supported, Least Significant Byte.		0x3C
	Bit 0. CL = 4 -		
	Bit 1. CL = 5 -		
	Bit 2 (Always 1). CL = 6 -	X	

	Bit 3. CL = 7 -	X	
	Bit 4. CL = 8 -	X	
	Bit 5. CL = 9 -	X	
	Bit 6. CL = 10 -		
	Bit 7. CL = 11 -		
15	CAS Latencies Supported, Most Significant Byte.		0x00
	Bit 0. CL = 12 -		
	Bit 1. CL = 13 -		
	Bit 2. CL =14 -		
	Bit 3. CL = 15 -		
	Bit 4. CL = 16 -		
	Bit 5. CL = 17 -		
	Bit 6. CL = 18 -		
	Bit 7. Reserved.		
16	Minimum CAS Latency Time (tAAmin).	13.125ns	0x69
17	Minimum Write Recovery Time (tWRmin).	15.0ns	0x78
18	Minimum RAS# to CAS# Delay Time (tRCDmin).	13.125ns	0x69
19	Minimum Row Active to Row Active Delay Time (tRRDmin).	6.0ns	0x30
20	Minimum Row Precharge Delay Time (tRPmin).	13.125ns	0x69
21	Upper Nibbles for tRAS and tRC		0x11
	Bit 3 ~ Bit 0. tRAS Most Significant Nibble -	1	
	Bit 7 ~ Bit 4. tRC Most Significant Nibble -	1	
22	Minimum Active to Precharge Delay Time (tRASmin), Least Significant Byte.	36.0ns	0x20
23	Minimum Active to Active/Refresh Delay Time (tRCmin), Least Significant Byte	49.125ns	0x89
24	Minimum Refresh Recovery Delay Time (tRFCmin), Least Significant Byte	160.0ns	0x00
25	Minimum Refresh Recovery Delay Time (tRFCmin), Most Significant Byte	160.0ns	0x05
26	Minimum Internal Write to Read Command Delay Time (tWTRmin)	7.5ns	0x3C
27	Minimum Internal Read to Precharge Command Delay Time (tRTPmin)	7.5ns	0x3C
28	Upper Nibble for tFAW.		0x00
	Bit 3 ~ Bit 0. tFAW Most Significant Nibble -	0	
	Bit 7 ~ Bit 4. Reserved -	0	
29	Minimum Four Activate Window Delay Time (tFAWmin), Least Significant Byte.	30.0ns	0xF0
30	SDRAM Optional Features		0x83
	Bit 0. RZQ / 6 -	X	
	Bit 1. RZQ / 7 -	X	
	Bit 6 ~ Bit 2. Reserved -		
	Bit 7. DLL-Off Mode Support		
31	SDRAM Drivers Supported.		0x01

	Extended Temperature Range -	X	
	Extended Temperature Refresh Rate -		
	Auto Self Refresh (ASR) -		
	On-die Thermal Sensor (ODTS) Readout -		
	Reserved -		
	Reserved -		
	Reserved -		
	Partial Array Self Refresh (PASR) -		
32	Module Thermal Sensor.		0x80
	Bit 6 ~ Bit 0. Thermal Sensor Accuracy -	0	
	Bit 7. Thermal Sensor -	With TS	
33	SDRAM Device Type.		0x00
	Bit 6 ~ Bit 0. Non-Standard Device Description -	0	
	Bit 7. SDRAM Device Type -	Std Mono	
34-59	Reserved	UNUSED	0x00
60	Module Nominal Height		0x0F
	Bit 4 ~ Bit 0. Module Nominal Height max, in mm -	29<h<=30	
	Bit 7 ~ Bit5. Reserved -	0	
61	Module Maximum Thickness		0x11
	Bit 3 ~ Bit 0. Front, in mm (baseline thickness = 1 mm) -	1<th<=2	
	Bit 7 ~ Bit 4. Back, in mm (baseline thickness = 1 mm) -	1<th<=2	
62	Reference Raw Card Used		0x24
	Bit 4 ~ Bit 0. Reference Raw Card -	R/C E	
	Bit 6, Bit 5. Reference Raw Card Revision -	Rev.1	
	Bit 7. Reserved -	0	
63	(Registered) DIMM Module Attributes.		0x09
	Bit 1 ~ Bit 0. # of Registers used on RDIMM -	1 Register	
	Bit 3 ~ Bit 2. # of Rows of DRAMs on RDIMM -	2 Rows	
	Bit 7 ~ Bit 4. Reserved -	0	
64	RDIMM Thermal Heat Spreader Solution.		0x00
	Bit 6 ~ Bit 0. Heat Spreader Thermal Characteristics -	0	
	Bit 7. Heat Spreader Solution -	No HS	
65	Register Manufacturer ID Code, Least Significant Byte (Optional)		0x80
66	Register Manufacturer ID Code, Most Significant Byte (Optional).		0xB3
67	Register Revision Number (Optional).		0x61
68	Register Type.		0x00
	Bit[2-0] Support Device -	SSTE32882	
	Bit[7-3] Reserved -	0	
69	[SSTE32882]: RC1 (MS Nibble) / RC0 (LS Nibble) - Reserved.	UNUSED	0x00
70	[SSTE32882]: RC3 (MS Nibble) / RC2 (LS Nibble) - Drive Strength, Command/Address.		0x50

71	Bit 1, Bit 0. RC2/DA3,4 Value.-	RESERVED	0x55
	Bit 3, Bit 2. RC2/DBA0,1 Value -	RESERVED	
	Bit 5, Bit 4. RC3/DA4,3 value, Command/Address A Outputs -	Moderate	
	Bit 7, Bit 6. RC3/DBA0,1 value, Command/Address B Outputs -	Moderate	
	SSTE32882]: RC5 (MS Nibble) / RC4 (LS Nibble) - Drive Strength, Control and Clock.		
	Bit 1, Bit 0. RC4/DA3,4 Control Signals, A Outputs.-	Moderate	
	Bit 3, Bit 2. RC4/DBA0,1 Control Signals, B Outputs -	Moderate	
	Bit 5, Bit 4. RC5/DA4,3 value, Y1/Y1# and Y3/Y3# Clock Outputs -	Moderate	
	Bit 7, Bit 6. RC5/DBA0,1 value, Y0/Y0# and Y2/Y2# Clock Outputs -	Moderate	
72	[SSTE32882]: RC7 (MS Nibble) / RC6 (LS Nibble) - Reserved.	UNUSED	0x00
73	[SSTE32882]: RC9 (MS Nibble) / RC8 (LS Nibble) - Reserved.	UNUSED	0x00
74	[SSTE32882]: RC11 (MS Nibble) / RC10 (LS Nibble) - Reserved.	UNUSED	0x00
75	[SSTE32882]: RC13 (MS Nibble) / RC12 (LS Nibble) - Reserved.	UNUSED	0x00
76	[SSTE32882]: RC15 (MS Nibble) / RC14 (LS Nibble) - Reserved.	UNUSED	0x00
77-116	Module-Specific Section	UNUSED	0x00
117	Module Manufacturer ID Code, Least Significant Byte		0x80
118	Module Manufacturer ID Code, Most Significant Byte		0xCE
119	Module Manufacturing Location		0x01
120	Module Manufacturing Date		0x10
121	Module Manufacturing Date		0x22
122	Module Serial Number		0x08
123	Module Serial Number		0x16
124	Module Serial Number		0xCC
125	Module Serial Number		0xEE
126	Cyclical Redundancy Code (CRC).		0x69
127	Cyclical Redundancy Code (CRC).		0x1D
128	Module Part Number	M	0x4D
129	Module Part Number	3	0x33
130	Module Part Number	9	0x39
131	Module Part Number	3	0x33
132	Module Part Number	B	0x42
133	Module Part Number	1	0x31
134	Module Part Number	K	0x4B
135	Module Part Number	7	0x37
136	Module Part Number	0	0x30
137	Module Part Number	C	0x43
138	Module Part Number	H	0x48
139	Module Part Number	0	0x30

140	Module Part Number	-	0x2D
141	Module Part Number	C	0x43
142	Module Part Number	H	0x48
143	Module Part Number	9	0x39
144	Module Part Number		0x20
145	Module Part Number		0x20
146	Module Revision Code	UNUSED	0x00
147	Module Revision Code	UNUSED	0x00
148	DRAM Manufacturer ID Code, Least Significant Byte		0x80
149	DRAM Manufacturer ID Code, Most Significant Byte		0xCE
150-175	Manufacturer's Specific Data	UNUSED	0x00
176-255	Open for customer use	UNUSED	0x00

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